



Docket Number (Optional) 03226.06400	Application Number 09/819,773
Applicant(s) Claude R. GAUTHIER, et al.	
Filing Date 03/28/2001	Group Art Unit 2836

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
							YES	NO
	A1	WO 01/17111 A1	03/08/2001	WIPO	G06F	17/50		

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

A2	PCT International Search Report dated 3/28/2002, 3 pgs.
A3	Benjamin Beker, et al.; "Tradeoffs in Modeling the Response of Power Delivery Systems of High-Performance Microprocessors"; IEEE 9th Topical Meeting on Electrical Performance of Electronic Packaging, Scottsdale, AZ, October 23-25, 2000; pgs. 77-80

EXAMINER <i>Almeida</i>	DATE CONSIDERED 6/28/04
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INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

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B1

Dennis J. Herrell, et al.; "Modeling of Power Distribution Systems for High-Performance Microprocessors"; IEEE Transactions on Advanced Packaging; Vol. 22, No. 3, August 1999, pp. 240-248

B2

Wiren D. Becker, et al.; "Modeling, Simulation, and Measurement of Mid-Frequency Simultaneous Switching Noise in Computer Systems"; IEEE Transactions on Components, Packaging, and Manufacturing Technology - Part B; Vol. 21, No. 2, May 1998; pp. 157-163

B3

Mondira Deb Pant, et al.; "On-Chip Decoupling Capacitor Optimization Using Architectural Level Current Signature Prediction"; 13th Annual IEEE International ASIC/SOC Conference; September 13-16, 2000; pp. 288-292

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